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Docket No.: 060188-0075

MAY 1 5 2006

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Customer Number: 20277

FUJIWARA, MAKOTO

Confirmation Number: 5700

Application No.: 09/867,766

Group Art Unit: 2134

Filed: May 31, 2001

Examiner: Poltorak, Piotr

For: SEMICONDUCTOR INTEGRATED CIRCUIT AND METHOD OF TESTING

SEMICONDUCTOR INTEGRATED CIRCUIT

REQUEST FOR RECONSIDERATION

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In response to the Office Action dated January 13, 2006, having a three-month shortened statutory period for response set to expire on April 13, 2006, and the petition for a one-month extension of time up to and including May 13, 2006 (Saturday) being filed concurrently herewith, reconsideration of the above-identified application is respectfully requested in view of the following remarks.